

MC74LVX4051

Analog Multiplexer/ Demultiplexer High-Performance Silicon-Gate CMOS

The MC74LVX4051 utilizes silicon-gate CMOS technology to achieve fast propagation delays, low ON resistances, and low leakage currents. This analog multiplexer/demultiplexer controls analog voltages that may vary across the complete power supply range (from V_{CC} to V_{EE}).

The LVX4051 is similar in pinout to the LVX8051, the HC4051A, and the metal-gate MC14051B. The Channel-Select inputs determine which one of the Analog Inputs/Outputs is to be connected, by means of an analog switch, to the Common Output/Input. When the Enable pin is HIGH, all analog switches are turned off.

The Channel-Select and Enable inputs are compatible with standard CMOS outputs. These inputs are overvoltage tolerant (OVT) for level translation from 6.0 V down to 3.0 V.

This device has been designed so the ON resistance (R_{ON}) is more linear over input voltage than the R_{ON} of metal-gate CMOS analog switches and High-Speed CMOS analog switches.

Features

- Fast Switching and Propagation Speeds
- Low Crosstalk Between Switches
- Analog Power Supply Range ($V_{CC} - V_{EE}$) = -3.0 V to +3.0 V
- Digital (Control) Power Supply Range ($V_{CC} - GND$) = 2.5 to 6.0 V
- Improved Linearity and Lower ON Resistance Than Metal-Gate, HSL, or VHC Counterparts
- Low Noise
- Designed to Operate on a Single Supply with $V_{EE} = GND$, or Using Split Supplies up to ± 3.0 V
- Break-Before-Make Circuitry
- These Devices are Pb-Free and are RoHS Compliant



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QFN16
MN SUFFIX
CASE 485AW

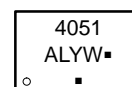


SOIC-16
D SUFFIX
CASE 751B

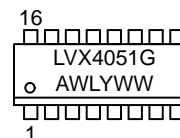


TSSOP-16
DT SUFFIX
CASE 948F

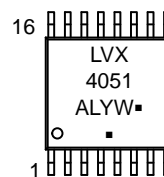
MARKING DIAGRAMS



QFN16



SOIC-16



TSSOP-16

LVX4051 = Specific Device Code
A = Assembly Location
WL, L = Wafer Lot
Y = Year
WW, W = Work Week
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

MC74LVX4051

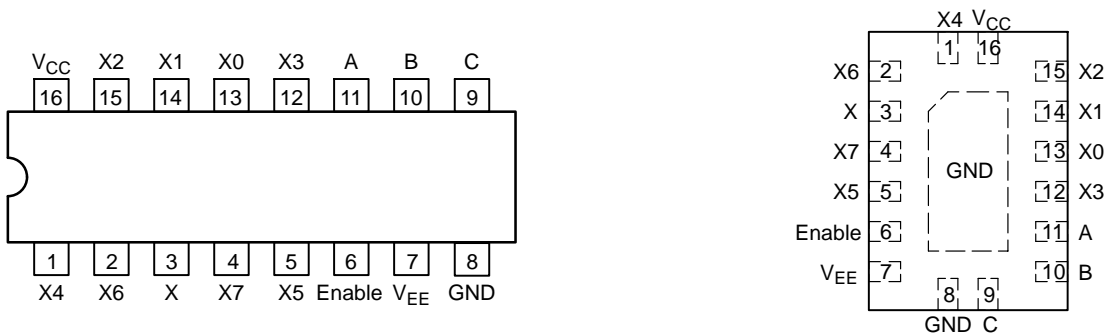


Figure 1. Pin Connection Diagrams
(Top View)

FUNCTION TABLE

| Control Inputs | | | | ON Channels |
|----------------|--------|---|---|-------------|
| Enable | Select | | | |
| | C | B | A | |
| L | L | L | L | X0 |
| L | L | L | H | X1 |
| L | L | H | L | X2 |
| L | L | H | H | X3 |
| L | H | L | L | X4 |
| L | H | L | H | X5 |
| L | H | H | L | X6 |
| L | H | H | H | X7 |
| H | X | X | X | NONE |

X = Don't Care

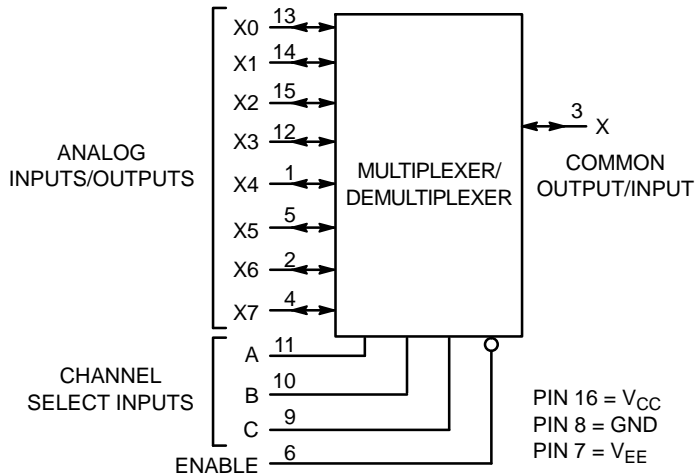


Figure 2. Logic Diagram
Single-Pole, 8-Position Plus Common Off

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|------------------|-----------------------|-----------------------|
| MC74LVX4051DG | SOIC-16 (Pb-Free) | 48 Units / Rail |
| MC74LVX4051DR2G | SOIC-16 (Pb-Free) | 2500 / Tape & Reel |
| MC74LVX4051DTG | TSSOP-16 (Pb-Free) | 96 Units / Rail |
| MC74LVX4051DTR2G | TSSOP-16 (Pb-Free) | 2500 / Tape & Reel |
| MC74LVX4051MNTWG | QFN-16 (Pb-Free) | 3000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MC74LVX4051

MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|---------------|---|--|---------|
| V_{EE} | Negative DC Supply Voltage (Referenced to GND) | -7.0 to +0.5 | V |
| V_{CC} | Positive DC Supply Voltage (Referenced to GND) (Referenced to V_{EE}) | 0.5 to + 7.0 -0.5 to + 7.0 | V |
| V_{IS} | Analog Input Voltage | $V_{EE} - 0.5$ to $V_{CC} + 0.5$ | V |
| V_{IN} | Digital Input Voltage (Referenced to GND) | -0.5 to 7.0 | V |
| I | DC Current, Into or Out of Any Pin | ±50 | mA |
| T_{STG} | Storage Temperature Range | -65 to +150 | °C |
| T_L | Lead Temperature, 1 mm from Case for 10 Seconds | 260 | °C |
| T_J | Junction Temperature under Bias | +150 | °C |
| θ_{JA} | Thermal Resistance | SOIC 143 TSSOP 164 | °C/W |
| P_D | Power Dissipation in Still Air, | SOIC 500 TSSOP 450 | mW |
| MSL | Moisture Sensitivity | Level 1 | |
| F_R | Flammability Rating | Oxygen Index: 30% – 35% UL 94-V0 @ 0.125 in | |
| V_{ESD} | ESD Withstand Voltage | Human Body Model (Note 1) > 2000 Machine Model (Note 2) > 200 Charged Device Model (Note 3) > 1000 | V |
| $I_{LATCHUP}$ | Latchup Performance | Above V_{CC} and Below GND at 125°C (Note 4) | ±300 mA |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Tested to EIA/JESD22-A114-A.
2. Tested to EIA/JESD22-A115-A.
3. Tested to JESD22-C101-A.
4. Tested to EIA/JESD78.

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Min | Max | Unit |
|------------|--|------------|------------|------|
| V_{EE} | Negative DC Supply Voltage (Referenced to GND) | -6.0 | GND | V |
| V_{CC} | Positive DC Supply Voltage (Referenced to GND) (Referenced to V_{EE}) | 2.5 2.5 | 6.0 6.0 | V |
| V_{IS} | Analog Input Voltage | V_{EE} | V_{CC} | V |
| V_{IN} | Digital Input Voltage (Note 5) (Referenced to GND) | 0 | 6.0 | V |
| T_A | Operating Temperature Range, All Package Types | -55 | 125 | °C |
| t_r, t_f | Input Rise/Fall Time (Channel Select or Enable Inputs) $V_{CC} = 3.0\text{ V} \pm 0.3\text{ V}$ $V_{CC} = 5.0\text{ V} \pm 0.5\text{ V}$ | 0 0 | 100 20 | ns/V |

5. Unused inputs may not be left open. All inputs must be tied to a high-logic voltage level or a low-logic input voltage level.

DEVICE JUNCTION TEMPERATURE VERSUS TIME TO 0.1% BOND FAILURES

| Junction Temperature °C | Time, Hours | Time, Years |
|-------------------------|-------------|-------------|
| 80 | 1,032,200 | 117.8 |
| 90 | 419,300 | 47.9 |
| 100 | 178,700 | 20.4 |
| 110 | 79,600 | 9.4 |
| 120 | 37,000 | 4.2 |
| 130 | 17,800 | 2.0 |
| 140 | 8,900 | 1.0 |

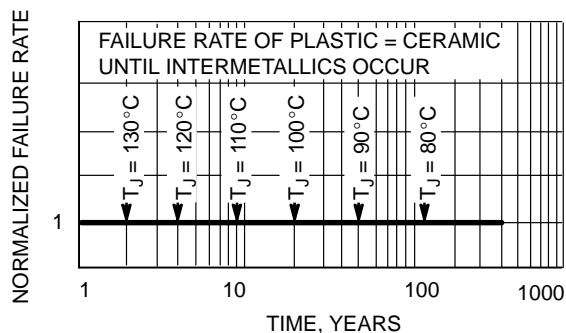


Figure 3. Failure Rate vs. Time Junction Temperature

MC74LVX4051

DC CHARACTERISTICS – Digital Section (Voltages Referenced to GND)

| Symbol | Parameter | Condition | V _{CC} V | Guaranteed Limit | | | Unit |
|-----------------|---|---|----------------------|------------------|-------|--------|------|
| | | | | -55 to 25°C | ≤85°C | ≤125°C | |
| V _{IH} | Minimum High-Level Input Voltage, Channel-Select or Enable Inputs | | 2.5 | 1.90 | 1.90 | 1.90 | V |
| | | | 3.0 | 2.10 | 2.10 | 2.10 | |
| | | | 4.5 | 3.15 | 3.15 | 3.15 | |
| | | | 6.0 | 4.2 | 4.2 | 4.2 | |
| V _{IL} | Maximum Low-Level Input Voltage, Channel-Select or Enable Inputs | | 2.5 | 0.6 | 0.6 | 0.6 | V |
| | | | 3.0 | 0.9 | 0.9 | 0.9 | |
| | | | 4.5 | 1.35 | 1.35 | 1.35 | |
| | | | 6.0 | 1.8 | 1.8 | 1.8 | |
| I _{IN} | Maximum Input Leakage Current, Channel-Select or Enable Inputs | V _{IN} = 6.0 or GND | 0 V to 6.0 V | ±0.1 | ±1.0 | ±1.0 | μA |
| I _{CC} | Maximum Quiescent Supply Current (per Package) | Channel Select, Enable and V _{IS} = V _{CC} or GND | 6.0 | 4.0 | 40 | 80 | μA |

DC ELECTRICAL CHARACTERISTICS – Analog Section

| Symbol | Parameter | Test Conditions | V _{CC} V | V _{EE} V | Guaranteed Limit | | | Unit |
|------------------|--|--|----------------------|----------------------|------------------|------------|------------|------|
| | | | | | -55 to 25°C | ≤85°C | ≤125°C | |
| R _{ON} | Maximum "ON" Resistance | V _{IN} = V _{IL} or V _{IH} V _{IS} = ½ (V _{CC} - V _{EE}) I _S = 2.0 mA (Figure 4) | 3.0 | 0 | 86 | 108 | 120 | Ω |
| | | | 4.5 | 0 | 37 | 46 | 55 | |
| | | | 3.0 | -3.0 | 26 | 33 | 37 | |
| ΔR _{ON} | Maximum Difference in "ON" Resistance Between Any Two Channels in the Same Package | V _{IN} = V _{IL} or V _{IH} V _{IS} = ½ (V _{CC} - V _{EE}) I _S = 2.0 mA | 3.0 | 0 | 15 | 20 | 20 | Ω |
| | | | 4.5 | 0 | 13 | 18 | 18 | |
| | | | 3.0 | -3.0 | 10 | 15 | 15 | |
| I _{off} | Maximum Off-Channel Leakage Current, Any One Channel | V _{in} = V _{IL} or V _{IH} ; V _{IO} = V _{CC} or GND; Switch Off (Figure 3) | 5.5 +3.0 | 0 -3.0 | 0.1 0.1 | 0.5 0.5 | 1.0 1.0 | μA |
| | Maximum Off-Channel Leakage Current, Common Channel | V _{in} = V _{IL} or V _{IH} ; V _{IO} = V _{CC} or GND; Switch Off (Figure 4) | 5.5 +3.0 | 0 -3.0 | 0.2 0.2 | 2.0 2.0 | 4.0 4.0 | |
| I _{on} | Maximum On-Channel Leakage Current, Channel-to-Channel | V _{in} = V _{IL} or V _{IH} ; Switch-to-Switch = V _{CC} or GND; (Figure 5) | 5.5 +3.0 | 0 -3.0 | 0.2 0.2 | 2.0 2.0 | 4.0 4.0 | μA |

AC CHARACTERISTICS (Input t_r = t_f = 3 ns)

| Symbol | Parameter | Test Conditions | V _{CC} V | V _{EE} V | Guaranteed Limit | | | | Unit |
|------------------|--------------------------------|--|----------------------|----------------------|------------------|------|-------|--------|------|
| | | | | | -55 to 25°C | | ≤85°C | ≤125°C | |
| | | | | | Min | Typ* | | | |
| t _{BBM} | Minimum Break-Before-Make Time | V _{IN} = V _{IL} or V _{IH} V _{IS} = V _{CC} R _L = 300 Ω, C _L = 35 pF (Figures 12 and 13) | 3.0 | 0.0 | 1.0 | 6.5 | - | - | ns |
| | | | 4.5 | 0.0 | 1.0 | 5.0 | - | - | |
| | | | 3.0 | -3.0 | 1.0 | 3.5 | - | - | |

*Typical Characteristics are at 25°C.

MC74LVX4051

AC CHARACTERISTICS ($C_L = 50$ pF, Input $t_r = t_f = 3$ ns)

| Symbol | Parameter | V_{CC} V | V_{EE} V | Guaranteed Limit | | | | | | Unit | |
|--------------------------|---|---------------|---------------|------------------|-----|-----|-------|-----|--------|------|-----|
| | | | | -55 to 25°C | | | ≤85°C | | ≤125°C | | |
| | | | | Min | Typ | Max | Min | Max | Min | | Max |
| t_{PLH} , t_{PHL} | Maximum Propagation Delay, Channel-Select to Analog Output (Figures 16 and 17) | 2.5 | 0 | | | 40 | | 45 | | 50 | ns |
| | | 3.0 | 0 | | | 28 | | 30 | | 35 | |
| | | 4.5 | 0 | | | 23 | | 25 | | 30 | |
| | | 3.0 | -3.0 | | | 23 | | 25 | | 28 | |
| t_{PLZ} , t_{PHZ} | Maximum Propagation Delay, Enable to Analog Output (Fig- ures 14 and 15) | 2.5 | 0 | | | 40 | | 45 | | 50 | ns |
| | | 3.0 | 0 | | | 28 | | 30 | | 35 | |
| | | 4.5 | 0 | | | 23 | | 25 | | 30 | |
| | | 3.0 | -3.0 | | | 23 | | 25 | | 28 | |
| t_{PZL} , t_{PZH} | Maximum Propagation Delay, Enable to Analog Output (Fig- ures 14 and 15) | 2.5 | 0 | | | 40 | | 45 | | 50 | ns |
| | | 3.0 | 0 | | | 28 | | 30 | | 35 | |
| | | 4.5 | 0 | | | 23 | | 25 | | 30 | |
| | | 3.0 | -3.0 | | | 23 | | 25 | | 28 | |

| | | Typical @ 25°C, $V_{CC} = 5.0$ V, $V_{EE} = 0$ V | | | Unit |
|-----------|--|--|--|-----|------|
| C_{PD} | Power Dissipation Capacitance (Figure 18) (Note 6) | 45 | | | pF |
| C_{IN} | Maximum Input Capacitance, Channel-Select or Enable Inputs | 10 | | | pF |
| $C_{I/O}$ | Maximum Capacitance (All Switches Off) | Analog I/O | | 10 | pF |
| | | Common O/I | | 10 | |
| | | Feedthrough | | 1.0 | |

6. Used to determine the no-load dynamic power consumption: $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$.

ADDITIONAL APPLICATION CHARACTERISTICS (GND = 0 V)

| Symbol | Parameter | Condition | V_{CC} V | V_{EE} V | Typ | Unit |
|-----------|---|--|---------------|---------------|------|------|
| | | | | | 25°C | |
| BW | Maximum On-Channel Bandwidth or Minimum Frequency Response | $V_{IS} = \frac{1}{2} (V_{CC} - V_{EE})$ Ref and Test Attn = 10 dB Source Amplitude = 0 dB (Figure 7) | 3.0 | 0.0 | 80 | MHz |
| | | | 4.5 | 0.0 | 80 | |
| | | | 6.0 | 0.0 | 80 | |
| | | | 3.0 | -3.0 | 80 | |
| V_{ISO} | Off-Channel Feedthrough Isolation | $f = 1$ MHz; $V_{IS} = \frac{1}{2} (V_{CC} - V_{EE})$ Adjust Network Analyzer output to 10 dBm on each output from the power splitter (Figures 8 and 9) | 3.0 | 0.0 | -70 | dB |
| | | | 4.5 | 0.0 | -70 | |
| | | | 6.0 | 0.0 | -70 | |
| | | | 3.0 | -3.0 | -70 | |
| V_{ONL} | Maximum Feedthrough On Loss | $V_{IS} = \frac{1}{2} (V_{CC} - V_{EE})$ Adjust Network Analyzer output to 10 dBm on each output from the power splitter (Figure 11) | 3.0 | 0.0 | -2 | dB |
| | | | 4.5 | 0.0 | -2 | |
| | | | 6.0 | 0.0 | -2 | |
| | | | 3.0 | -3.0 | -2 | |
| Q | Charge Injection | $V_{IN} = V_{CC}$ to V_{EE} , $f_{IS} = 1$ kHz, $t_r = t_f = 3$ ns $R_{IS} = 0$ Ω, $C_L = 1000$ pF, $Q = C_L \cdot \Delta V_{OUT}$ (Figure 10) | 5.0 | 0.0 | 9.0 | pC |
| | | | 3.0 | -3.0 | 12 | |
| THD | Total Harmonic Distortion THD + Noise | $f_{IS} = 1$ MHz, $R_L = 10$ KΩ, $C_L = 50$ pF, $V_{IS} = 5.0$ V _{PP} sine wave $V_{IS} = 6.0$ V _{PP} sine wave (Figure 19) | 6.0 | 0.0 | 0.10 | % |
| | | | 3.0 | -3.0 | 0.05 | |

MC74LVX4051

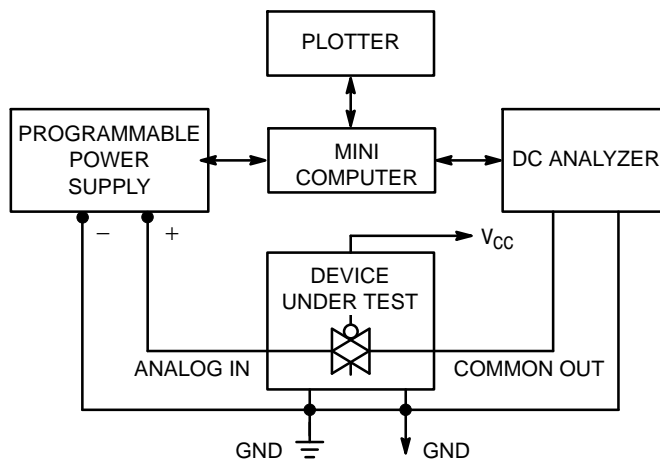


Figure 4. On Resistance, Test Set-Up

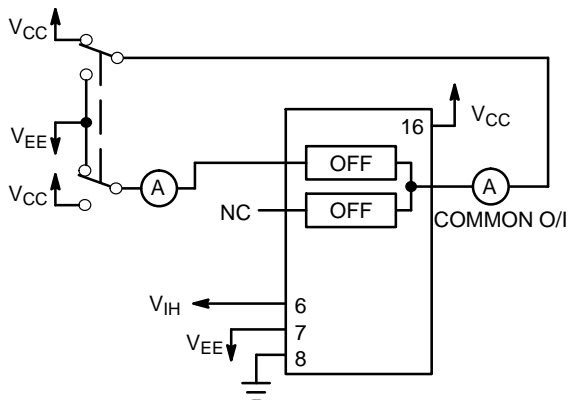


Figure 5. Maximum Off Channel Leakage Current, Any One Channel, Test Set-Up

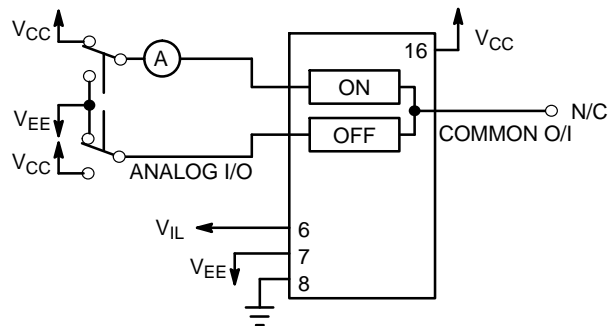


Figure 6. Maximum On Channel Leakage Current, Channel to Channel, Test Set-Up

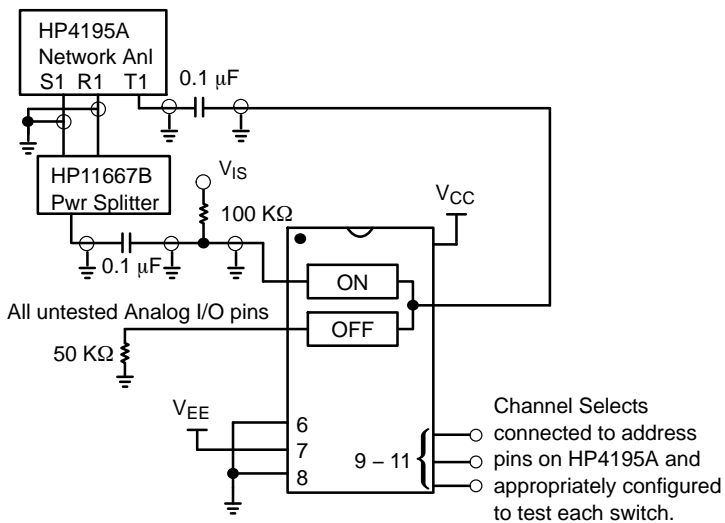
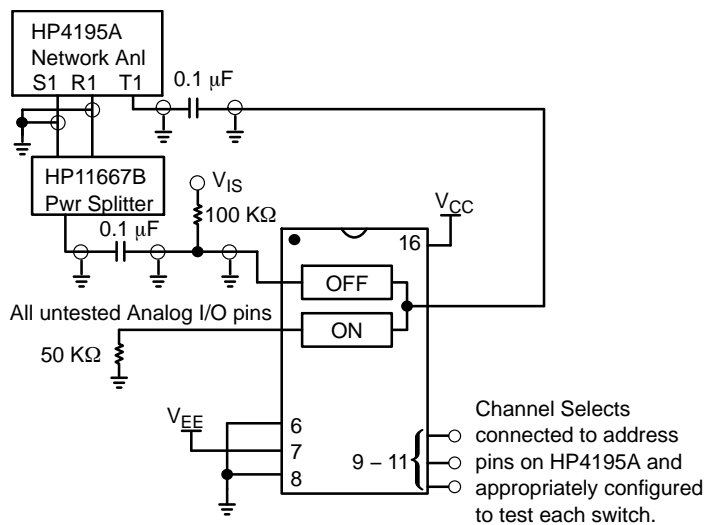


Figure 7. Maximum On Channel Bandwidth, Test Set-Up

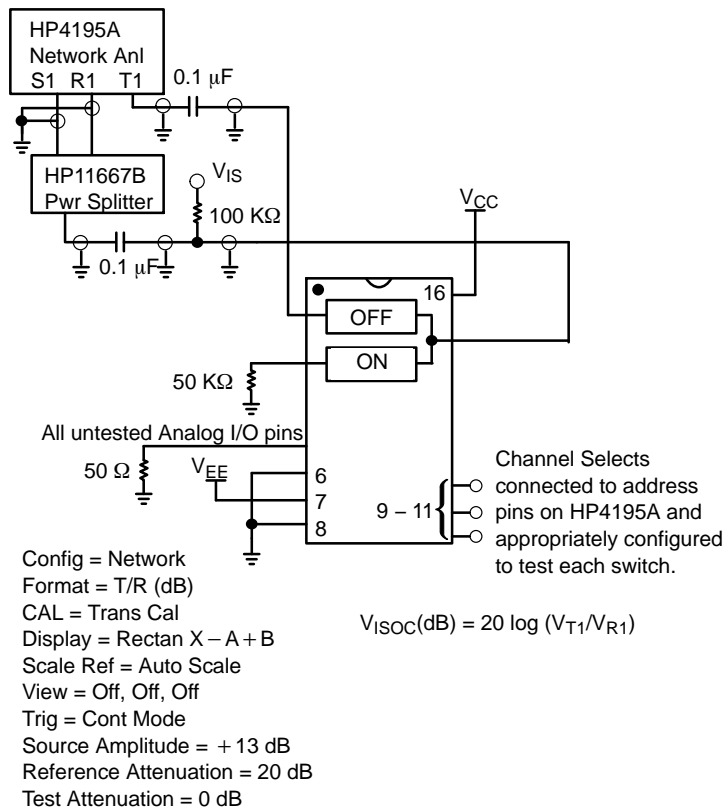
MC74LVX4051



Config = Network
 Format = T/R (dB)
 CAL = Trans Cal
 Display = Rectan X - A + B
 Scale Ref = Auto Scale
 View = Off, Off, Off
 Trig = Cont Mode
 Source Amplitude = + 13 dB
 Reference Attenuation = 20 dB
 Test Attenuation = 0 dB

$$V_{ISO}(dB) = 20 \log (V_{T1}/V_{R1})$$

Figure 8. Maximum Off Channel Feedthrough Isolation, Test Set-Up

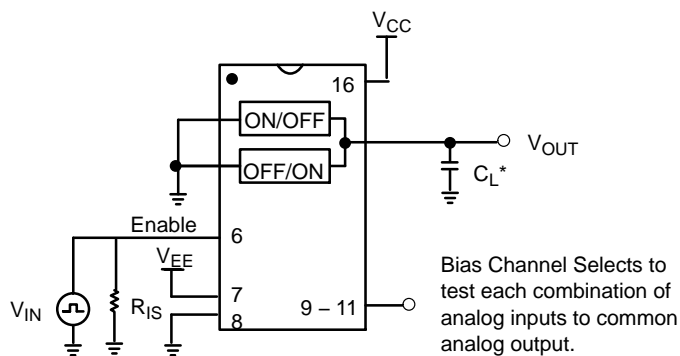


Config = Network
 Format = T/R (dB)
 CAL = Trans Cal
 Display = Rectan X - A + B
 Scale Ref = Auto Scale
 View = Off, Off, Off
 Trig = Cont Mode
 Source Amplitude = + 13 dB
 Reference Attenuation = 20 dB
 Test Attenuation = 0 dB

$$V_{ISOC}(dB) = 20 \log (V_{T1}/V_{R1})$$

Figure 9. Maximum Common-Channel Feedthrough Isolation, Test Set-Up

MC74LVX4051



*Includes all probe and jig capacitance.

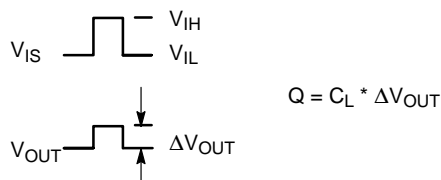


Figure 10. Charge Injection, Test Set-Up

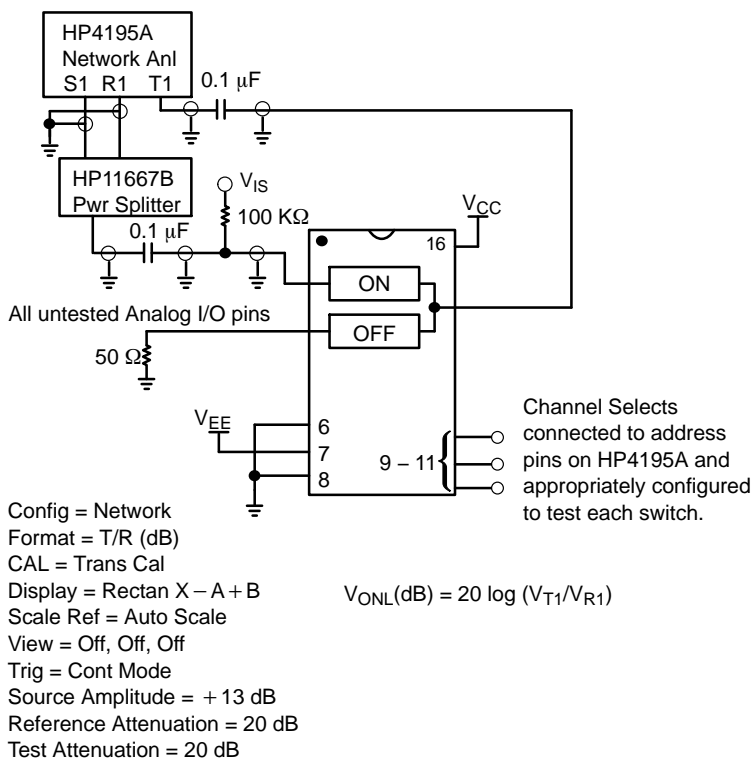


Figure 11. Maximum On Channel Feedthrough On Loss, Test Set-Up

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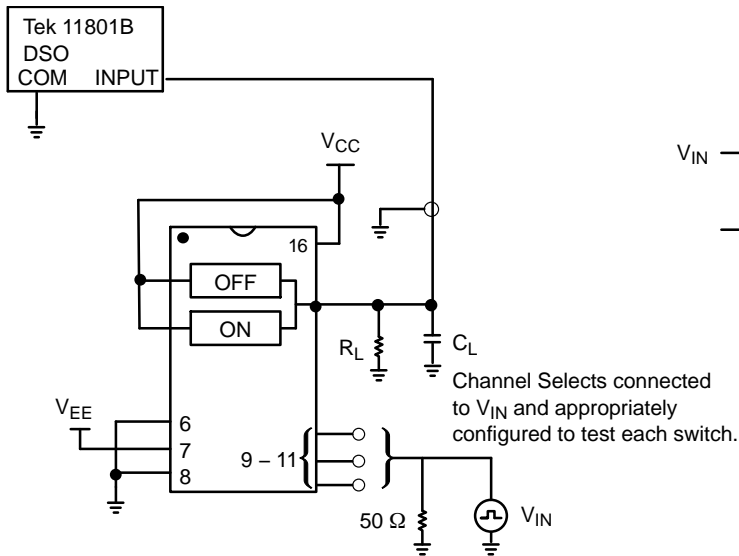


Figure 12. Break-Before-Make, Test Set-Up

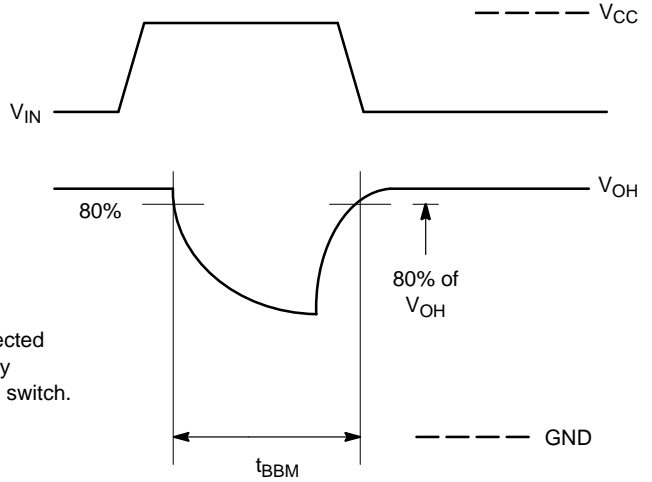


Figure 13. Break-Before-Make Time

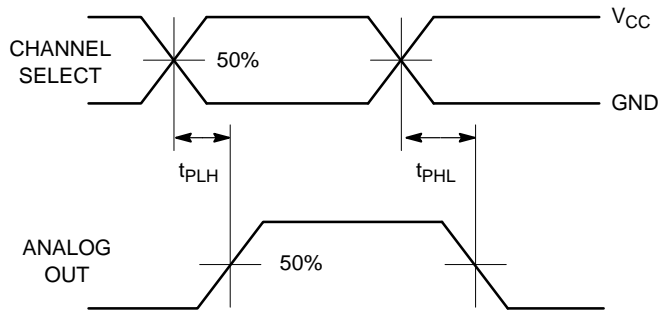
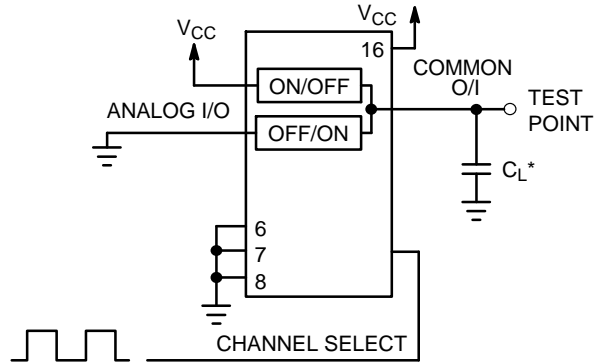


Figure 14. Propagation Delays, Channel Select to Analog Out



*Includes all probe and jig capacitance.

Figure 15. Propagation Delay, Test Set-Up Channel Select to Analog Out

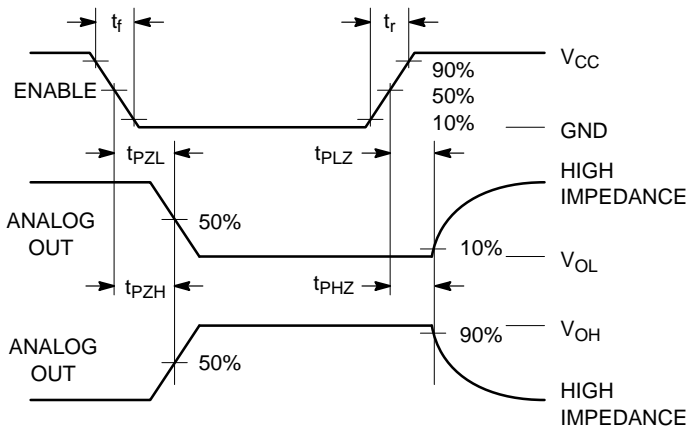


Figure 16. Propagation Delays, Enable to Analog Out

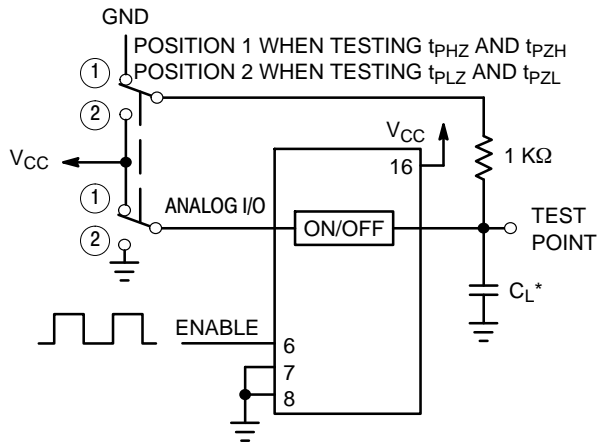


Figure 17. Propagation Delay, Test Set-Up Enable to Analog Out

MC74LVX4051

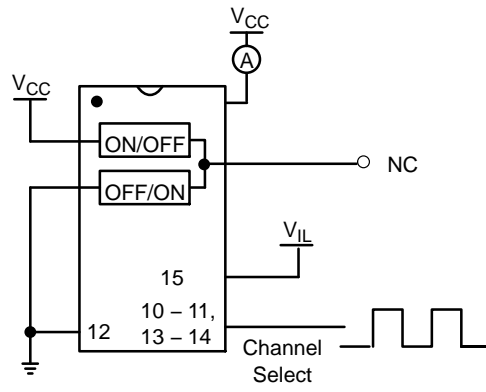


Figure 18. Power Dissipation Capacitance, Test Set-Up



Figure 19. Total Harmonic Distortion, Test Set-Up

APPLICATIONS INFORMATION

The Channel Select and Enable control pins should be at V_{CC} or GND logic levels. V_{CC} being recognized as a logic high and GND being recognized as a logic low. In this example:

$$V_{CC} = +5 \text{ V} = \text{logic high}$$

$$GND = 0 \text{ V} = \text{logic low}$$

The maximum analog voltage swing is determined by the supply voltages V_{CC} and V_{EE} . The positive peak analog voltage should not exceed V_{CC} . Similarly, the negative peak analog voltage should not go below V_{EE} . In this example, the difference between V_{CC} and V_{EE} is five volts. Therefore, using the configuration of Figure 21, a maximum analog signal of five volts peak-to-peak can be controlled. Unused analog inputs/outputs may be left floating (i.e., not connected). However, tying unused analog inputs and

outputs to V_{CC} or GND through a low value resistor helps minimize crosstalk and feedthrough noise that may be picked up by an unused switch.

Although used here, balanced supplies are not a requirement. The only constraints on the power supplies are that:

$$V_{EE} - GND = 0 \text{ to } -6 \text{ volts}$$

$$V_{CC} - GND = 2.5 \text{ to } 6 \text{ volts}$$

$$V_{CC} - V_{EE} = 2.5 \text{ to } 6 \text{ volts}$$

$$\text{and } V_{EE} \leq GND$$

When voltage transients above V_{CC} and/or below V_{EE} are anticipated on the analog channels, external Germanium or Schottky diodes (D_x) are recommended as shown in Figure 22. These diodes should be able to absorb the maximum anticipated current surges during clipping.

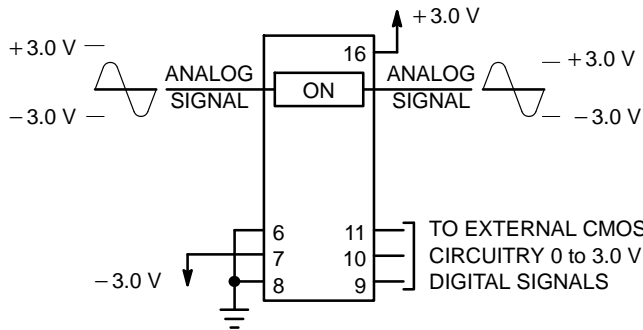


Figure 20. Application Example

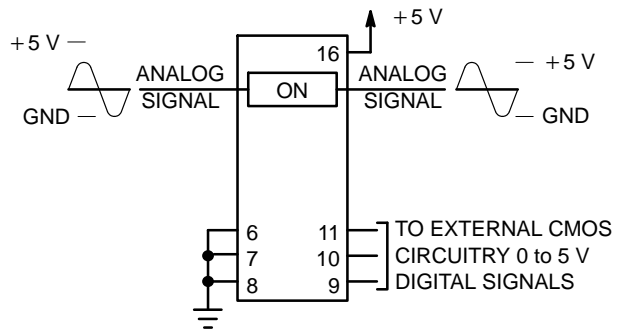


Figure 21. Application Example

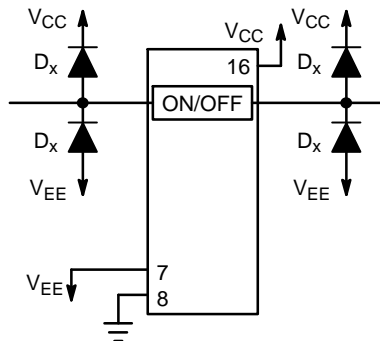


Figure 22. External Germanium or Schottky Clipping Diodes

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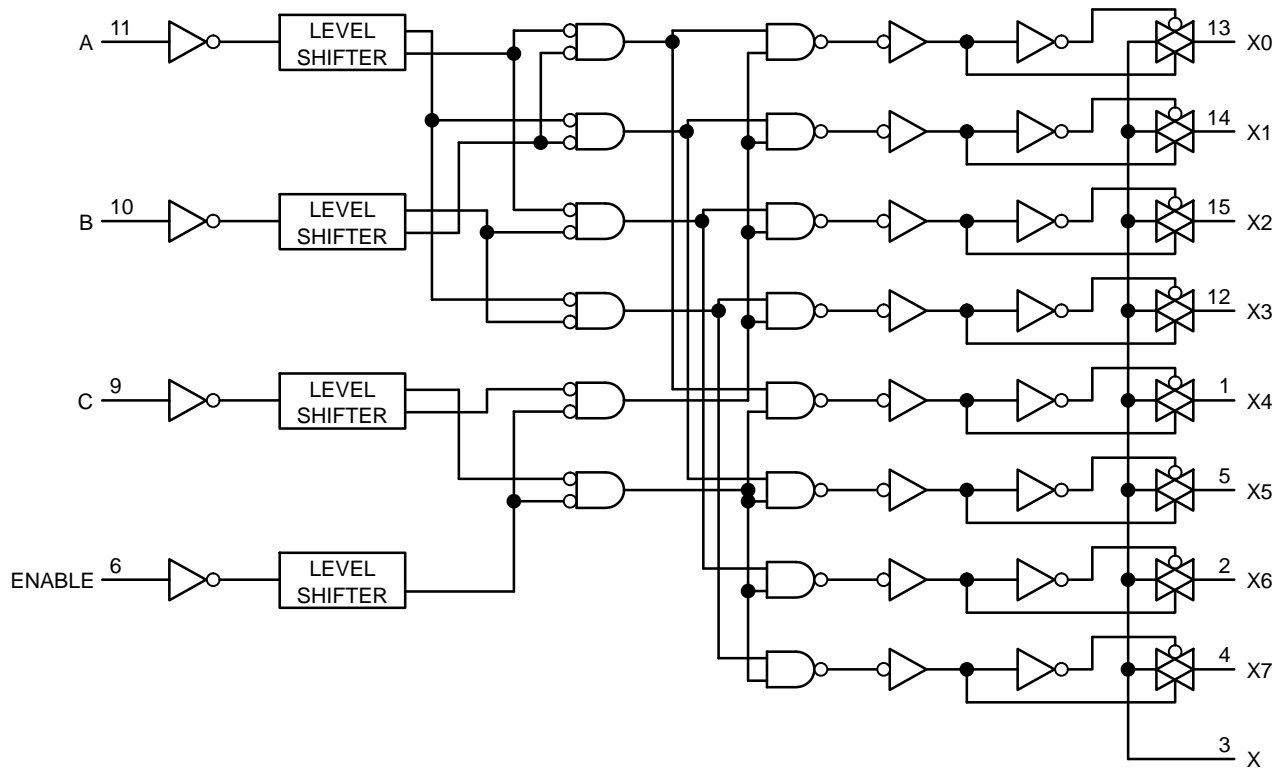


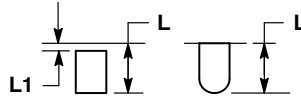
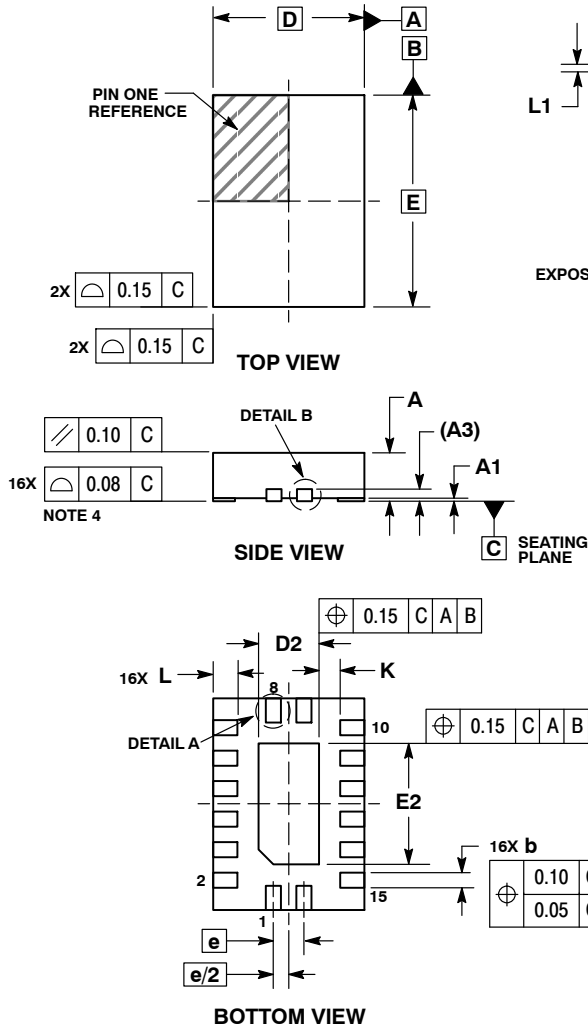
Figure 23. Function Diagram, LVX4051



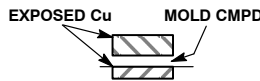
SCALE 2:1

QFN16, 2.5x3.5, 0.5P
CASE 485AW-01
ISSUE 0

DATE 11 DEC 2008



DETAIL A
ALTERNATE TERMINAL CONSTRUCTIONS



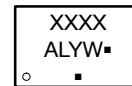
DETAIL B
ALTERNATE CONSTRUCTIONS

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSIONS b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM TERMINAL.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS | |
|-----|-------------|------|
| | MIN | MAX |
| A | 0.80 | 1.00 |
| A1 | 0.00 | 0.05 |
| A3 | 0.20 REF | |
| b | 0.20 | 0.30 |
| D | 2.50 BSC | |
| D2 | 0.85 | 1.15 |
| E | 3.50 BSC | |
| E2 | 1.85 | 2.15 |
| e | 0.50 BSC | |
| K | 0.20 | --- |
| L | 0.35 | 0.45 |
| L1 | --- | 0.15 |

GENERIC MARKING DIAGRAM*

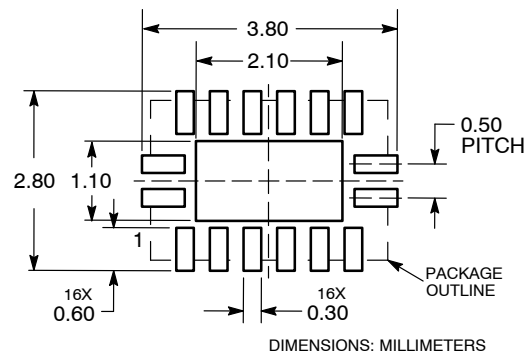


- XXXX = Specific Device Code
- A = Assembly Location
- L = Wafer Lot
- Y = Year
- W = Work Week
- = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present.

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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| DESCRIPTION: | QFN16, 2.5X3.5, 0.5P | PAGE 1 OF 1 |

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MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

ON Semiconductor®



SCALE 1:1

SOIC-16 CASE 751B-05 ISSUE K

DATE 29 DEC 2006



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|-------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 9.80 | 10.00 | 0.386 | 0.393 |
| B | 3.80 | 4.00 | 0.150 | 0.157 |
| C | 1.35 | 1.75 | 0.054 | 0.068 |
| D | 0.35 | 0.49 | 0.014 | 0.019 |
| F | 0.40 | 1.25 | 0.016 | 0.049 |
| G | 1.27 BSC | | 0.050 BSC | |
| J | 0.19 | 0.25 | 0.008 | 0.009 |
| K | 0.10 | 0.25 | 0.004 | 0.009 |
| M | 0° | 7° | 0° | 7° |
| P | 5.80 | 6.20 | 0.229 | 0.244 |
| R | 0.25 | 0.50 | 0.010 | 0.019 |

- | | | | |
|---|---|---|---|
| <p>STYLE 1:</p> <p>PIN 1. COLLECTOR 2. BASE 3. EMITTER 4. NO CONNECTION 5. EMITTER 6. BASE 7. COLLECTOR 8. COLLECTOR 9. BASE 10. EMITTER 11. NO CONNECTION 12. EMITTER 13. BASE 14. COLLECTOR 15. EMITTER 16. COLLECTOR</p> | <p>STYLE 2:</p> <p>PIN 1. CATHODE 2. ANODE 3. NO CONNECTION 4. CATHODE 5. CATHODE 6. NO CONNECTION 7. ANODE 8. CATHODE 9. CATHODE 10. ANODE 11. NO CONNECTION 12. CATHODE 13. CATHODE 14. NO CONNECTION 15. ANODE 16. CATHODE</p> | <p>STYLE 3:</p> <p>PIN 1. COLLECTOR, DYE #1 2. BASE, #1 3. EMITTER, #1 4. COLLECTOR, #1 5. COLLECTOR, #2 6. BASE, #2 7. EMITTER, #2 8. COLLECTOR, #2 9. COLLECTOR, #3 10. BASE, #3 11. EMITTER, #3 12. COLLECTOR, #3 13. COLLECTOR, #4 14. BASE, #4 15. EMITTER, #4 16. COLLECTOR, #4</p> | <p>STYLE 4:</p> <p>PIN 1. COLLECTOR, DYE #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. COLLECTOR, #3 6. COLLECTOR, #3 7. COLLECTOR, #4 8. COLLECTOR, #4 9. BASE, #4 10. EMITTER, #4 11. BASE, #3 12. EMITTER, #3 13. BASE, #2 14. EMITTER, #2 15. BASE, #1 16. EMITTER, #1</p> |
| <p>STYLE 5:</p> <p>PIN 1. DRAIN, DYE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. DRAIN, #3 6. DRAIN, #3 7. DRAIN, #4 8. DRAIN, #4 9. GATE, #4 10. SOURCE, #4 11. GATE, #3 12. SOURCE, #3 13. GATE, #2 14. SOURCE, #2 15. GATE, #1 16. SOURCE, #1</p> | <p>STYLE 6:</p> <p>PIN 1. CATHODE 2. CATHODE 3. CATHODE 4. CATHODE 5. CATHODE 6. CATHODE 7. CATHODE 8. CATHODE 9. ANODE 10. ANODE 11. ANODE 12. ANODE 13. ANODE 14. ANODE 15. ANODE 16. ANODE</p> | <p>STYLE 7:</p> <p>PIN 1. SOURCE N-CH 2. COMMON DRAIN (OUTPUT) 3. COMMON DRAIN (OUTPUT) 4. GATE P-CH 5. COMMON DRAIN (OUTPUT) 6. COMMON DRAIN (OUTPUT) 7. COMMON DRAIN (OUTPUT) 8. SOURCE P-CH 9. SOURCE P-CH 10. COMMON DRAIN (OUTPUT) 11. COMMON DRAIN (OUTPUT) 12. COMMON DRAIN (OUTPUT) 13. GATE N-CH 14. COMMON DRAIN (OUTPUT) 15. COMMON DRAIN (OUTPUT) 16. SOURCE N-CH</p> | |

SOLDERING FOOTPRINT



DIMENSIONS: MILLIMETERS

| | | |
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MECHANICAL CASE OUTLINE

PACKAGE DIMENSIONS

ON Semiconductor®



TSSOP-16
CASE 948F-01
ISSUE B

DATE 19 OCT 2006



NOTES:

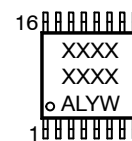
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 4.90 | 5.10 | 0.193 | 0.200 |
| B | 4.30 | 4.50 | 0.169 | 0.177 |
| C | --- | 1.20 | --- | 0.047 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.65 BSC | | 0.026 BSC | |
| H | 0.18 | 0.28 | 0.007 | 0.011 |
| J | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| K | 0.19 | 0.30 | 0.007 | 0.012 |
| K1 | 0.19 | 0.25 | 0.007 | 0.010 |
| L | 6.40 BSC | | 0.252 BSC | |
| M | 0° | 8° | 0° | 8° |

SOLDERING FOOTPRINT



GENERIC MARKING DIAGRAM*



- XXXX = Specific Device Code
- A = Assembly Location
- L = Wafer Lot
- Y = Year
- W = Work Week
- G or ■ = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present.

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